

<b>Form PTO-1449</b> U.S. Department of Commerce Patent & Trademark Office				Atty. Docket No. 6564		Serial No. 09/706,747	
<b>INFORMATION DISCLOSURE STATEMENT</b> (Use several sheets if necessary)							
				Applicant Suranjan PANIGRAHI et al.			
				Filing Date November 7, 2000		Group Unknown	
<b>U.S. PATENT DOCUMENTS</b>							
Examiner Initial		Document Number	Date	Name	Class	Sub- Class	Filing Date (if appropriate)
VXH	AA	5,751,421	05/12/98	Wright et al.	356	328	
VXH	AB	5,991,025	11/23/99	Wright et al.	356	328	
VXH	AC	5,898,792	04/27/99	Oste et al.	382	110	
VXH	AD	4,540,282	09/10/85	Landa et al.	356	328	
VXH	AE	3,597,616	08/03/71	Brunton et al.	250	83.3	
VXH	AF	4,040,747	08/09/77	Webster	356	188	
VXH	AG	4,253,766	03/03/81	Funk	356	418	
VXH	AH	4,260,262	04/07/81	Webster	356	418	
VXH	AI	4,463,261	07/31/84	Bowman	250	339	
VXH	AJ	4,560,275	12/24/85	Goetz	356	326	
<b>OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)</b>							
VXH	AK	Randy Nouis, Predicting the Ninety-Fifth Percentile Dust Environment for Passenger Vehicles in the Continental United States, March 1-5, 1993, pp. 1-11					
VXH	AL	C. S. Chang et al., Grain Flow Regulator for Dust Emission Control, November - December, 1985, pp. 2059-2062					
VXH	AM	Joseph A. Borgia et al., Pressure Drop and Flow Characteristics for a Heavy-Duty Air Filter During Dust Loading, November 16-19, 1987, pp. 1-15					
VXH	AN	Charles O. Reinhart et al., Measurement of Engine Air Cleaner Efficiency Using Airborne Particle Size Analysis, September 12-15, 1983, pp. 1-8					
VXH	AO	Philip C. Williams, et al.; Determination of Protein and Moisture in Wheat and Barley by Near-Infrared Transmission, 1985, pp. 239-244					
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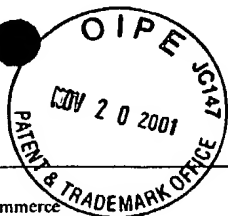
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VX/H	AA	4,806,764	02/21/89	Satake	250	339	
	AB	4,925,305	05/15/90	Erickson	356	300	
	AC	4,997,280	03/05/91	Norris	356	308	
	AD	5,132,538	07/21/92	Norris	250	339	
	AE	5,239,180	08/24/93	Clarke	250	339	
	AF	5,241,178	08/31/93	Shields	250	339	
	AG	5,308,981	05/03/94	Perten	250	339.01	
	AH	5,406,084	04/11/95	Tobler et al.	250	339.01	
	AI	5,517,302	05/14/96	Stearns et al.	356	326	
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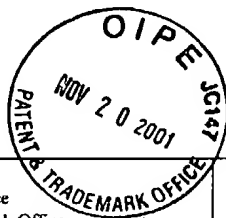
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VXA	AA	4,037,970	07/26/77	Webster et al.	356	188	
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	AG	Donald A. Burns, Handbook of Near-Infrared Analysis, pp. Contents 53-106					
	AH	P. C. Williams et al., Effect of Mutual Interactions on the Estimation of Protein and Moisture in Wheat, 11/24/82					
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VXIH	AI	Huaipu Song et al., Neural Network Classification of Wheat Using Single Kernel Near-Infrared Transmittance Spectra, October 1995, pp. 2927-2934				
VXIH	AJ	Stephen R. Delwiche, Single Wheat Kernel Analysis by Near-Infrared Transmittance: Protein Content, 1995, pp. 11-16				
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VXIH	AL	Near-Infrared Reflectance Method for Protein Determination, pp. 1-2				
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VXH	AH	Suming Chen et al., "Neural Network Analysis of Sugar Content in Fruit Juice", 07/18-21/99, pp. Title page thru 12					
	AI	Renfu Lu et al., "Determination of Sugar Content and Firmness of Apples Using Near-Infrared Diffuse Reflectance", 07/9-12, 00, pp. Title page thru 16					
	AJ	K. J. Kaffka et al., "Attempts to Determine Oil, Protein, Water and Fiber Content in Sunflower Seeds by the NIR Technique", 1983, pp117-129					
	AK	Essex E. Finney, Jr. et al., "Determination of Moisture in Corn Kernels by Near-Infrared Transmittance Measurements", 1978, pp 581-584,					
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	AM	D. T. Lamb et al., "Moisture Determination in Single Soybean Seeds by Near-Infrared Transmittance", 1991, pp 2123-2129					
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	AO	D. Wang et al., "Effect of Wheat Kernel Size and Orientation on Reflectance Spectra and Single Kernel Color Classification", 1997, pp 1-34					
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VXH	AA	5,578,931	11/26/96	Russell et al.	324	536	
	AB	5,218,529	06/08/93	Meyer et al.	702	028	
	AC	5,844,086	12/01/98	Murray	530	377	
	AD	6,005,076	12/21/99	Murray	530	377	
	AE	5,351,338	09/27/94	Wigren	704	219	
	AF	5,986,749	11/16/99	Wu et al.	356	073.1	
	AG	4,649,281	03/10/87	Schmitt et al.	250	574	
	AH	4,448,790	05/15/84	Sarkki et al.	426	052	
	AI	5,410,021	04/25/95	Kampen	530	372	
VXH	AJ	5,472,511	12/05/95	Rayas et al.	127	067	
<b>OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)</b>							
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	AL	Stermer et al., "Infrared Reflectance Spectroscopy for Estimation of Moisture of Whole Grain", 1977, pp345-351					
	AM	F. E. Dowell et al., "Automated Single Wheat Kernel Quality Measurement Using Near-Infrared Reflectance", 1997, pp 1,3,5,7, and 9					
	AN	B. G. Osborne, "Recent Progress in the Application of NIR to the Measurement of Quality Parameters in Flour", 1982, pp577-581					
	AO	J. S. Shenk, "How NIR Can Help in Measuring Forage Quality for Breeding and Utilization Programs", (3) pages					
VXH	AP	Gerard Downey, "Estimation of Moisture in Undried Wheat and Barley by Near Reflectance", 1985, pp951-958					
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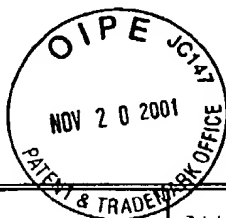
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VXH	AA	4,836,017	06/06/89	Bozek	073	152.42	
	AB	5,755,672	05/26/98	Arai et al.	600	547	
	AC	3,886,331	05/27/75	Schierer	356	308	
	AD	5,317,524	05/31/94	Das et al.	702	134	
	AE	5,442,438	08/15/95	Batchelder et al.	356	301	
	AF	5,689,333	11/18/97	Batchelder et al.	356	301	
	AG	3,876,881	04/08/75	Bohlen	250	361.C	
	AH	5,130,158	07/14/92	Otsubo et al.	426	622	
VXH	AI	5,173,079	12/22/92	Gerrish	460	007	
	AJ						
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VXH	AK	Doninique Bertrand et al., "Application of Principal Component Analysis to the Prediction of Lucerne Forage Protein Content and <i>in vitro</i> Dry Matter Digestibility by NIR Spectroscopy", 1987, pp299-307					
	AL	Shuso Kawamura et al., "Determining Undried Rough Rice Constituent Content Using Near-Infrared Transmission Spectroscopy", 1997, pp cover, 1,3,5, and 7					
	AM	Holger M. Jaenisch et al., "Instrumentation to Measure the Near-IR Spectrum of Small Fruits", 1990, pp162-166					
	AN	Paul Geladi et al., "Partial Least-Squares Regression: A Tutorial", 1985, pp1-17					
	AO	Constantinos Goutis, "Second-Derivative Functional Regression with Applications to Near Infra-Red Spectroscopy", 1998, pp103-114					
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	AC	5,619,618	04/08/97	Bigus	395	23	
	AD	5,617,511	04/01/97	Bigus	375	26	
	AE	5,697,373	12/16/97	Richards-Kortum et al.	128	664	
	AF	5,559,034	09/24/96	Roberts et al.	435	320.1	
	AG	5,605,577	02/25/97	Rayas et al.	127	67	
	AH	4,108,847	08/22/78	Creinin et al.	260	112 G	
	AI	6,001,412	12/14/99	Huber et al.	426	656	
VXIT	AJ	3,578,866	05/18/71	Kohler et al.	356	74	
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VXIT	AK	John S. Shenk et al., "Near Infrared Reflectance Analysis with Single-and Multiproduct Calibrations", 1993, pp582-584					
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	AM	F. E. Barton et al., "The Calibration of NIR Reflectance Spectrometer for the Determination of Diverse Compositional Parameters", 1988, pp 768-773					
	AN	R. J. Barnes et al.; "Standard Normal Variate Transformation and De-Trending of Near-Infrared Diffuse Reflectance Spectra", 1989, pp772-777					
	AO	Kurt C. Lawrence et al., "Sensing Wheat Moisture Content Independent of Density", 1997, pp Cover Page, 1,3,5,7,9,11,13 and 15					
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	AB	3,776,642	12/04/73	Anson et al.	356	188	
	AC	5,478,748	12/26/95	Akins et al.	436	86	
	AD	4,866,644	09/12/89	Shenk et al.	364	571.02	
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	AJ	"Comments on the Savitzky-Golay Convolution Method for Least-Squares Fit Smoothing and Differentiation of Digital Data", 1978, pp1383-1386
	AK	Gerald S. Birth et al., "Interaction Between Light and Natural Materials: Laboratory Demonstrations", (4) Cover Pages, and pp1-36
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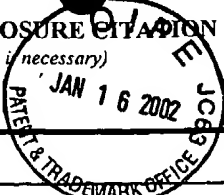


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	AL	"Comments on Smoothing and Differentiation of Data by Simplified Least Square Procedure", 1972, pp 1906-1910				
	AM	Edward K. Baldwin, Ph.D., "Calibrating Near Infrared Instruments for On-Line Food Processing Measurements", pp 252-265				
	AN	P. D. Wilson et al., "Polynomial Filters of any Degree", 1981, pp 599-603				
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EXAMINER <i>Hien V.</i>	DATE CONSIDERED <i>7/7/04</i>
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EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP Section 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

